

FUJI POWER MOSFET Super FAP-G Series

■ Features

- | | |
|------------------------|-------------------|
| High speed switching | Low on-resistance |
| No secondary breakdown | Low driving power |
| Avalanche-proof | |

■ Applications

- | | |
|------------------------------------|------------------|
| Switching regulators | DC-DC converters |
| UPS (Uninterruptible Power Supply) | |

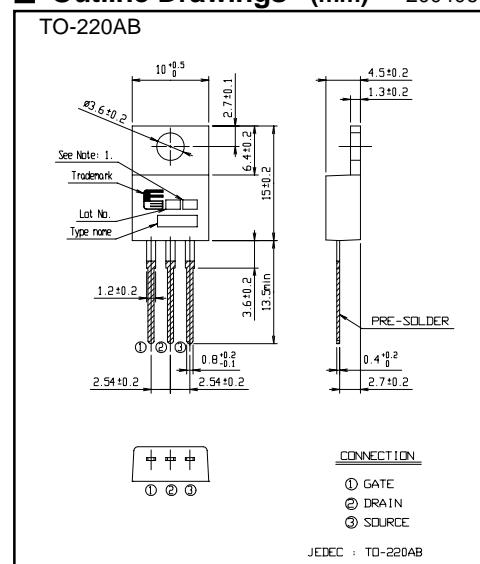
■ Maximum ratings and characteristic

- Absolute maximum ratings
($T_c=25^\circ\text{C}$ unless otherwise specified)

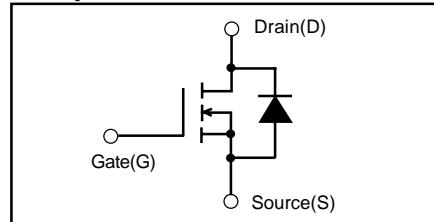
Item	Symbol	Ratings	Unit	Remarks
Drain-source voltage	V_{DS}	250	V	
	V_{DSX}	220	V	$V_{GS}=-30\text{V}$
Continuous Drain Current	I_D	14	A	
Pulsed Drain Current	$I_D(\text{puls})$	± 56	A	
Gate-Source Voltage	V_{GS}	± 30	V	
Maximum Avalanche current	I_{AR}	14	A	Note *1
Non-Repetitive	E_{AS}	301.1	mJ	Note *2
Maximum Avalanche Energy				
Repetitive	E_{AR}	10.5	mJ	Note *3
Maximum Avalanche Energy				
Maximum Drain-Source dV/dt	dV_{DS}/dt	20	kV/ μs	$V_{DS}\leq 250\text{V}$
Peak Diode Recovery dV/dt	dV/dt	5	kV/ μs	Note *4
Peak Diode Recovery -di/dt	-di/dt	100	A/ μs	Note *5
Max. Power Dissipation	P_D	105	W	$T_c=25^\circ\text{C}$
		2.02		$T_a=25^\circ\text{C}$
Operating and Storage Temperature range	T_{ch}	+150	°C	
	T_{stg}	-55 to +150	°C	

● Electrical characteristics ($T_c=25^\circ\text{C}$ unless otherwise specified)

■ Outline Drawings (mm) 200406



■ Equivalent circuit schematic



Note *1: $T_{ch}\leq 150^\circ\text{C}$, Repetitive and Non-repetitive

Note *2: Starting $T_{ch}=25^\circ\text{C}$, $I_{AS}=6\text{A}$, $L=14.1\text{mH}$, $V_{cc}=48\text{V}$, $R_g=50\Omega$

EAS limited by maximum channel temperature and avalanche current.

See to the 'Avalanche Energy' graph

Note *3: Repetitive rating: Pulse width limited by maximum channel temperature.

See to the 'Transient Thermal impedance' graph

Note *4: $I_f \leq -I_D$, $-di/dt=100\text{A}/\mu\text{s}$, $V_{cc}\leq BV_{DSS}$, $T_{ch}\leq 150^\circ\text{C}$

Note *5: $I_f \leq -I_D$, $dv/dt=5\text{kV}/\mu\text{s}$, $V_{cc}\leq BV_{DSS}$, $T_{ch}\leq 150^\circ\text{C}$

Item	Symbol	Test Conditions	Min.	Typ.	Max.	Units
Drain-Source Breakdown Voltagel	BV_{DSS}	$I_D=250\mu\text{A}$ $V_{GS}=0\text{V}$	250			V
Gate Threshold Voltage	$V_{GS(\text{th})}$	$I_D=250\mu\text{A}$ $V_{DS}=V_{GS}$		3.0		V
Zero Gate Voltage Drain Current	I_{DSS}	$V_{DS}=250\text{V}$ $V_{GS}=0\text{V}$ $T_{ch}=25^\circ\text{C}$			25	μA
		$V_{DS}=200\text{V}$ $V_{GS}=0\text{V}$ $T_{ch}=125^\circ\text{C}$			2.0	mA
Gate-Source Leakage Current	I_{GS}	$V_{GS}=\pm 30\text{V}$ $V_{DS}=0\text{V}$			100	nA
Drain-Source On-State Resistance	$R_{DS(on)}$	$I_D=7\text{A}$ $V_{GS}=10\text{V}$		220	280	$\text{m}\Omega$
Forward Transconductance	g_{fs}	$I_D=7\text{A}$ $V_{DS}=25\text{V}$	5	10		S
Input Capacitance	C_{iss}	$V_{DS}=75\text{V}$		780	1170	pF
Output Capacitance	C_{oss}	$V_{GS}=0\text{V}$		90	135	
Reverse Transfer Capacitance	C_{rss}	$f=1\text{MHz}$		6.0	9.0	
Turn-On Time t_{on}	$t_{d(on)}$	$V_{cc}=48\text{V}$ $I_D=7\text{A}$			12	18
	t_r	$V_{GS}=10\text{V}$			3	4.5
Turn-Off Time t_{off}	$t_{d(off)}$	$R_{GS}=10\Omega$			23	35
	t_f				6	9
Total Gate Charge	Q_G	$V_{cc}=125\text{V}$			22	33
Gate-Source Charge	Q_{GS}	$I_D=14\text{A}$			7.0	11
Gate-Drain Charge	Q_{GD}	$V_{GS}=10\text{V}$			6.0	9.0
Diode forward on-voltage	V_{SD}	$I_f=14\text{A}$ $V_{GS}=0\text{V}$ $T_{ch}=25^\circ\text{C}$			1.00	1.50
Reverse recovery time	t_{rr}	$I_f=14\text{A}$ $V_{GS}=0\text{V}$			120	250
Reverse recovery charge	Q_{rr}	$-di/dt=100\text{A}/\mu\text{s}$ $T_{ch}=25^\circ\text{C}$			0.5	1.25

● Thermal characteristics

Item	Symbol	Test Conditions	Min.	Typ.	Max.	Units
Thermal resistance	$R_{th(ch-c)}$	channel to case			1.191	$^\circ\text{C}/\text{W}$
	$R_{th(ch-a)}$	channel to ambient			62	$^\circ\text{C}/\text{W}$

■ Characteristics

